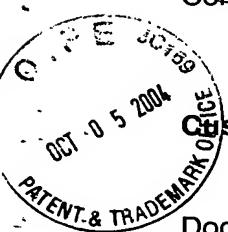


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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Docket No. GK-ZEI-3156 / 500343.20157 Confirm No.: 2875
Applicant(s): Ralf WOLLESCHENSKY, et al. Allowed: 07/14/04
Application No.: 10/081,096 Group: 2878
Filed: February 21, 2002 Examiner: Otilia Gabor
For: ARRANGEMENT FOR THE OPTICAL CAPTURE OF EXCITED AND/OR
BACKSCATTERED LIGHT BEAM IN A SAMPLE

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INFORMATION DISCLOSURE STATEMENT

SIR:

Applicants wish to make of record the following reference, which was cited in a related patent application:

	Document Number	Date	Name and/or Country
AA	5,329,352	04/12/1994	Jacobsen

Accompanying this Information Disclosure Statement and form PTO-1449 is a copy of the document.

This submission is not an admission that the information disclosed in the documents is material to the patentability of the invention disclosed and/or claimed in the above-identified application.

Respectfully submitted,


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GHK:ram
10/05/04
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Enclosures:
PTO-1449
w/document



LIST OF PRIOR ART CITED BY APPLICANT
 (Filed on October 5, 2004)

Docket No. **GK-ZEY3156/500343.20157**Applicant(s): **Ralf WOLLESCHENSKY and Michael KEMPE**Application No. **10/081,096**Group: **2878**Filed: **February 21, 2002**Examiner: **Otilia Gabor****U.S. PATENT DOCUMENTS**

Exam. Init		Document Number	Date	Name	Class	Sub-Class	Filing Date Appropriate
	AA	5,329,352	04/12/1994	Jacobsen			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	CLASS	Sub-Class	Translation
							YES
							NO
	AL						
	AM						
	AN						
	AO						
	AP						
	AQ						
	AR						
	AS						

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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